

## 课程大纲

### COURSE SYLLABUS

1.	<b>课程代码/名称</b> <b>Course Code/Title</b>	集成电路材料与工艺 Silicon VLSI Technology, Fundamentals, Practice and Modelling																						
2.	<b>课程性质</b> <b>Compulsory/Elective</b>	专业核心课 Major Core Courses																						
3.	<b>课程学分/学时</b> <b>Course Credit/Hours</b>	3/64																						
4.	<b>授课语言</b> <b>Teaching Language</b>	英 中 English & Chinese																						
5.	<b>授课教师</b> <b>Instructor(s)</b>	崔德虎 Cui Dehu																						
6.	<b>先修要求</b> <b>Pre-requisites</b>	半导体器件 Semiconductor device																						
7.	<b>教学目标</b> <b>Course Objectives</b>	<p>课程介绍硅超大规模集成电路芯片生产制造相关的实际工艺技术，讲解这些工艺技术背后的科学工艺过程的物理图像 以及测量方法。包括 CMOS 工艺技术，光刻，刻蚀，薄膜沉积，真空技术，离子注入，化学物理沉积，等离子体技术，薄膜分析等。</p> <p>This lecture focuses on the basic features of the silicon integrated circuits manufacture, including their distinctions and common underlying principle. Such as: CMOS Technology, lithography, etching, various deposition techniques, vacuum technology, evaporation, ion implantation, epitaxy, chemical vapour deposition, plasma, film analysis.</p>																						
8.	<b>教学方法</b> <b>Teaching Methods</b>	讲授 Lectures, 实验/实习 Lab/Practical																						
9.	<b>教学内容</b> <b>Course Contents</b>	<table border="1" style="width: 100%; border-collapse: collapse;"> <tr> <td style="text-align: center;"><b>Section 1</b></td> <td>晶体生长：晶圆片制造与硅晶圆片的基本特性，圆片的准备和规格； Crystal Growth, Wafer fabrication and basic properties of silicon wafer</td> </tr> <tr> <td style="text-align: center;"><b>Section 2</b></td> <td>半导体制造——洁净室、晶圆片清洗与吸杂处理； Semiconductor manufacturing, clean rooms, wafer cleaning and guttering</td> </tr> <tr> <td style="text-align: center;"><b>Section 3-4</b></td> <td>光刻；Lithography</td> </tr> <tr> <td style="text-align: center;"><b>Section 5</b></td> <td>热氧化；Thermal oxidation</td> </tr> <tr> <td style="text-align: center;"><b>Section 6</b></td> <td>高 K/金属栅；High-K dielectrics/Metal gate</td> </tr> <tr> <td style="text-align: center;"><b>Section 7-8</b></td> <td>扩散；Diffusion</td> </tr> <tr> <td style="text-align: center;"><b>Section 9</b></td> <td>薄膜淀积；Thin film deposition</td> </tr> <tr> <td style="text-align: center;"><b>Section 10</b></td> <td>刻蚀.；Etching</td> </tr> <tr> <td style="text-align: center;"><b>Section 11</b></td> <td></td> </tr> <tr> <td style="text-align: center;"><b>Section 12</b></td> <td></td> </tr> <tr> <td style="text-align: center;">.....</td> <td></td> </tr> </table>	<b>Section 1</b>	晶体生长：晶圆片制造与硅晶圆片的基本特性，圆片的准备和规格； Crystal Growth, Wafer fabrication and basic properties of silicon wafer	<b>Section 2</b>	半导体制造——洁净室、晶圆片清洗与吸杂处理； Semiconductor manufacturing, clean rooms, wafer cleaning and guttering	<b>Section 3-4</b>	光刻；Lithography	<b>Section 5</b>	热氧化；Thermal oxidation	<b>Section 6</b>	高 K/金属栅；High-K dielectrics/Metal gate	<b>Section 7-8</b>	扩散；Diffusion	<b>Section 9</b>	薄膜淀积；Thin film deposition	<b>Section 10</b>	刻蚀.；Etching	<b>Section 11</b>		<b>Section 12</b>		.....	
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<b>10.</b>	<b>课程考核</b> <b>Course Assessment</b>
	请再此注明：①考试；②分数构成。 课堂表现 Class Performance            10% 期末考试 Final Exam                    40% 课程报告 Class Presentation            50%
<b>11.</b>	<b>教材及其它参考资料</b> <b>Textbook and Supplementary Readings</b>
	超大规模集成电路工艺技术：理论，实践及模型。 Silicon VLSI Technology, Fundamentals, Practice and Modelling